

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
SHIMADA, TAKUYA

Examiner

DUNG D. TRAN

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0227977	11-2004	Yoshida, Seishin	358/003.01
*	B	US-7,345,798	03-2008	Kondo, Hirokazu	358/523
*	C	US-6,204,940	03-2001	Lin et al.	358/527
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

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